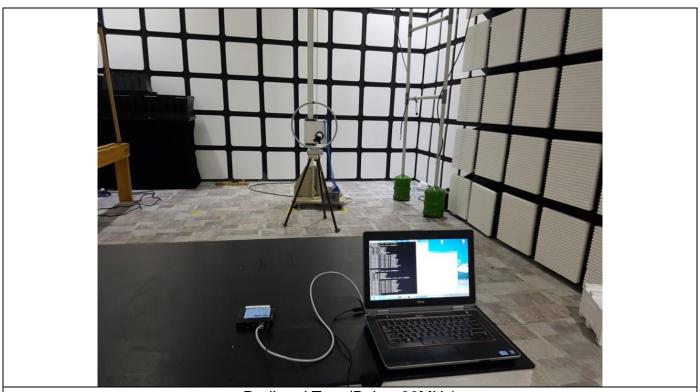
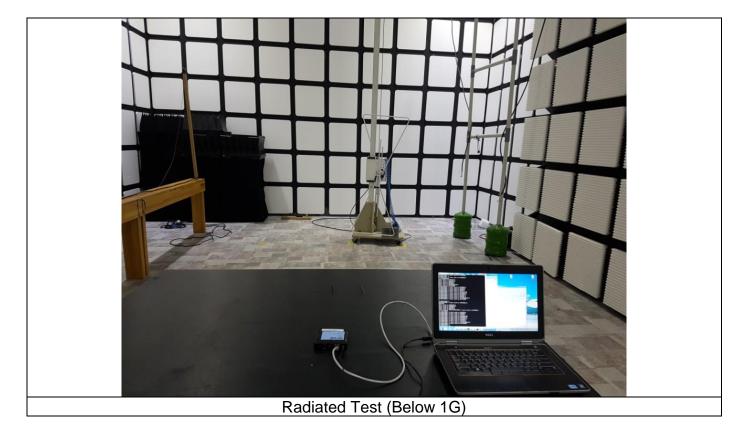


Appendix 1. Test Setup Photos



Radiated Test (Below 30MHz)



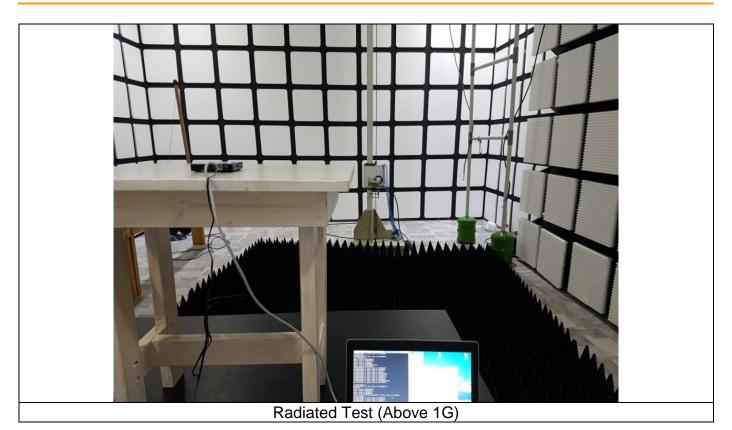
Appendix 1.
Test Setup Photos

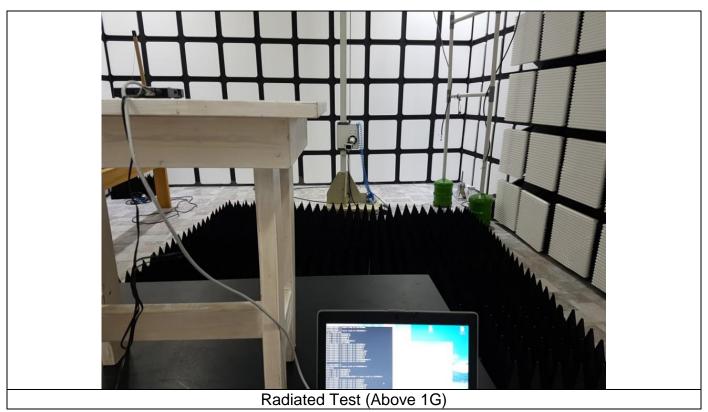
BWS TECH Inc.

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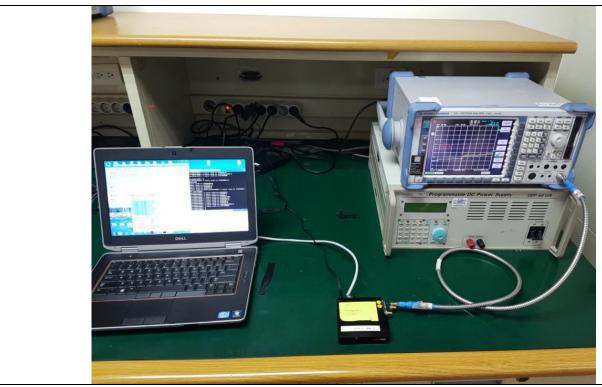






BWS TECH Inc. Test Setup Photos Issue Date: February 22, 2018





Conducted Test 1



Conducted Test 2

BWS TECH Inc.

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A. Setup photo of EUT

Photo of radiated spurious emission at below 30MHz



Photo of radiated spurious emission at $30 \text{MHz} \sim 1~000 \text{MHz}$

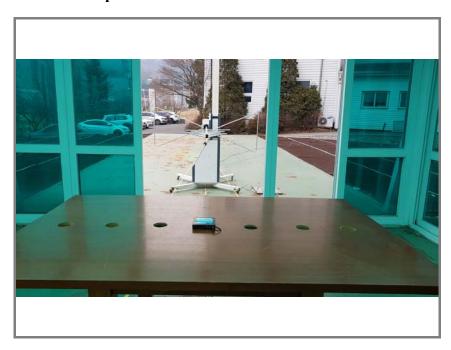
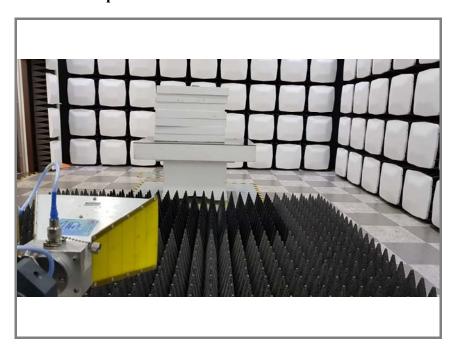
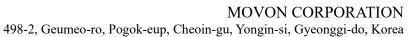


Photo of radiated spurious emission at above 1 000MHz











Test setup photo of EUT



MOVON CORPORATION

498-2, Geumeo-ro, Pogok-eup, Cheoin-gu, Yongin-si, Gyeonggi-do, Korea

A. Setup photo of EUT

Photo of radiated spurious emission at below 30MHz

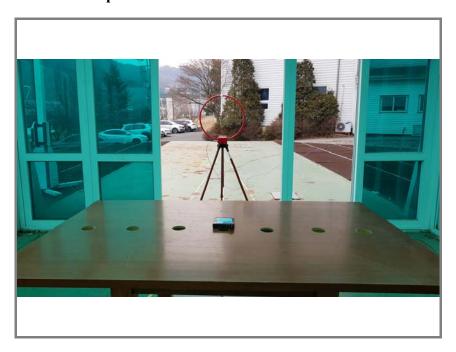
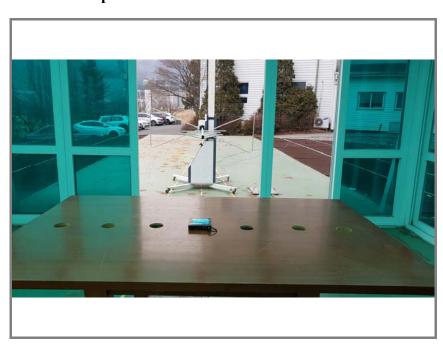


Photo of radiated spurious emission at $30 \text{MHz} \sim 1~000 \text{MHz}$

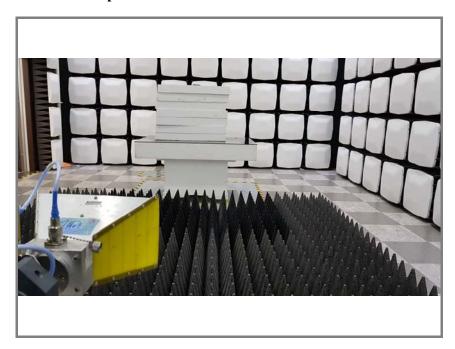




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Photo of radiated spurious emission at above 1 000MHz







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Photo of conducted test setup

